Search Notes Application/Control No. Applicant(s)/Patent Under Reexamination EROL ET AL. Examiner Quoc, Tran A Art Unit 2176

SEARCHED					
Class	Subclass	Date	Examiner		
715	512	4/22/2007	QT		
386	95	4/22/2007	QT		
345	732	4/22/2007	QT		
Updated Above	Updated Above	12/6/2007	QT		
Updated 715	Updated 209, 233, 704, 714, 716, 730-733	7/10/2008	QT		

SEARCH NOTES					
Search Notes	Date	Examiner			
Updated Search EAST (USPAT, USPGPUB, JPO, USOCR, FPRS, EPO,	4/22/2007	QT			
DERWENT & IBM_TDB)					
Inventors Searched Conducted- Considered Double Patent Rejection	4/22/2007	QT			
Updated Above	12/6/2007	QT			
Updated Above	7/10/2008	QT			
Text Search Class 715/ 209, 233, 704, 714, 716, 730-733	7/10/2008	QT			
NPL Search (IEEE Database)	7/10/2008	QT			

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